S	Search Notes							

Application/Control No.	Applicant(s)/Patent under Reexamination
10/665,974	DEEM ET AL.
Examiner	Art Unit
Michael Doffloy	2720

	SEARCHED				
Class	Subclass	Date	Examiner		
606	27-31, 41,47- 50,213	1/10/2006	MP		
607	101,102	1/10/2006	MP		
607	122	1/10/2006	MP		
128	898	1/10/2006	MP		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
1	t			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Checked STIC Search in 10/679,245	1/10/2006	MP		